



Analysis of Cyber Attacks Against Distribution-Level PMUs: Event Source Location Case Study

(Tasks 1.2, 1.3, and 2.2)

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Application of Micro-PMUs:

- Capacitor Back Switching
- Fault Analysis
- Lightning Analysis
- Inverter Misoperation
- Event Classification
- Event Clustering
- Impedance Calculation
- Topology Identification
- Event Source Location Identification
- ...

Distribution Synchrophasors

By Hamed Mohsenian-Rad,
Emma Stewart, and Ed Cortez

IN THE EVOLUTION OF ADVANCED SENSING TECHNOLOGIES, transmission systems have led distribution. The visibility and diagnosis of the grid have been transformed over the past decade with the systematic deployment of phaser measurement units (PMUs). Similar and even more advanced new information sources are now emerging at the distribution level, called distribution-level PMUs, also called *micro-PMUs* (μ PMUs). μ PMUs provide voltage and current measurements at higher resolution and precision, facilitating a level of visibility into the distribution grid that is currently unavailable.

However, mere data availability in itself will not lead to enhanced situational awareness and operational intelligence.

Data must be paired with useful analytics to translate raw data to meaningful insights.

In this article, we explore some of the opportunities to leverage μ PMU data,

combined with data-driven analytics, to help electrical distribution system planners and operators to get in front

of problems as they arise.

The data generated by μ PMUs are a prominent example of big data in power systems. Each μ PMU generates 124,416,600 readings per day. Therefore, μ PMUs introduce a huge volume of data that must be efficiently collected, cleaned, and processed, all in real time.

The collected μ PMU data must then be dissected into

descriptive, predictive, and prescriptive analytics.

While descriptive analytics focuses on what happened in the past,

predictive analytics aims at what may happen in the future.

Prescriptive analytics is concerned with actions to take,

optimizing the future with informed decisions. Here, we

consider case studies in both descriptive and predictive

analytics and provide a sampling of the benefits derived

from

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Our Focus

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6345

Locating the Source of Events in Power Distribution Systems Using Micro-PMU Data

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Abstract—A novel method is proposed to locate the source of events in power distribution systems by using distribution-level phasor measurement unit (PMU) data. The main idea of this paper is defined rather broadly to include any major change in any component across the distribution feeder. The goal is to enhance the reliability of power distribution systems by detection of the operation (or misoperation) of various grid equipment, assets, distribution energy resources, loads, etc. The proposed method builds the time-varying voltage phasor magnitude profile to indicate an equivalent circuit to represent the event by using voltage and current synchronphasors that are captured by micro-PMUs. Importantly, the proposed method can detect both transient events but also synchronized phase angle measurements, thus, it justifies the need for micro-PMUs in distribution systems. The proposed method uses the recorded data from micro-PMUs to detect voltage and current sensors. The proposed method can work with data from as few as a few or only two micro-PMUs. The effectiveness of the developed method is demonstrated on the IEEE 123-bus test system, the IEEE 123-bus test system, and also on micro-PMU's measurement data from the 12.47 kV distribution system of CA. The results verify that the proposed method is accurate and robust in locating the source of different types of events on power distribution systems.

Index Terms—Distribution transformer, micro-PMUs, event source location, power quality and reliability analysis, data-driven method, compensation theory, measurement difference.

I. INTRODUCTION

DISTRIBUTION-LEVEL phasor measurement units (PMUs), a.k.a., micro-PMUs (μ PMUs), have been introduced as new sensor technologies to enhance real-time monitoring in power distribution systems. Micro-PMUs provide high-resolution measurements of voltage/phases, voltage and current phasors at a high resolution (120 Hz or more per second) [1]. Several emerging applications of micro-PMUs, including model validation, distribution system state estimation, topology detection, phasor identification, distributed generation,

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Fig. 1. Voltage phasor magnitude that is measured in a distribution substation in Riverside, CA. Two cases are shown here. Event 1 is a noise case in the transmission system, Event 2 is a noise case in the distribution system.

and transient analysis, as discussed in a recent survey in [2] and the references therein.

A. Motivation

Consider one minute of voltage phasor measurements in Fig. 1 from a micro-PMU at a real-life 12.47 kV distribution substation in Riverside, CA. As expected, there are fluctuations in voltage magnitude and two voltage sag events. Each event is not cause at either a local equipment or level or network [3]. Common root causes of distribution level events include load switching, capacitor bank switching, connection or disconnection of large loads, lightning strikes, equipment malfunction, a minor fault, etc. Accordingly, in this paper, we seek to answer the following question: for those events with root cause unknown, what is the location of the event? In other words, *at what exact distribution bus does the load switching, capacitor bank switching, DER connection/disconnection, or device malfunction occur?*

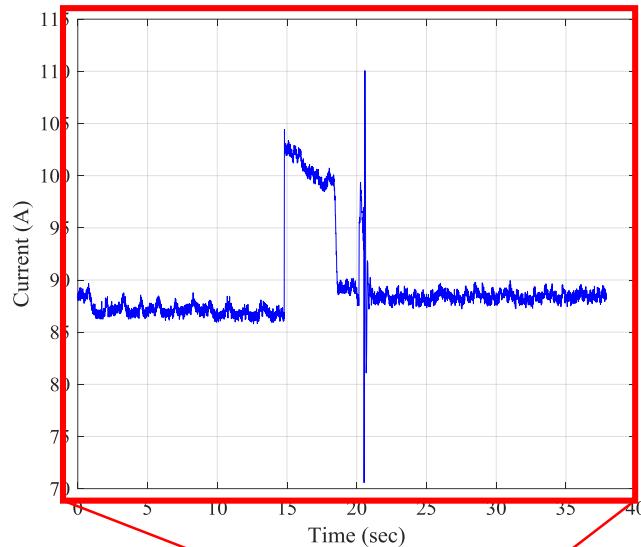
The motivation behind this research is to bring attention to the interesting situation in power distribution systems, so as to keep track of how various grid equipment, assets, DERs, and loads operate. In addition, the distribution system operator needs to quickly identify and contain failure [11] or cyber attacks [5], so as to reduce demand side resources to construct a self-organizing power distribution system [16]–[18]. Here, an event is defined as a change in the voltage magnitude profile of a specific segment across the power distribution feeder. This of course includes the two traditional classes of electric distribution system events, namely voltage sags and overvoltages. These events are often caused by above normal nodal power limit, as well as reliability events, such as interrupting service due to faults that cause fuse blowing or relay tripping [9]. However, since the goal in this paper is to detect events in power distribution systems, we are interested also in PQ events that do not necessarily violate PQ requirements or undermine reliability, but they

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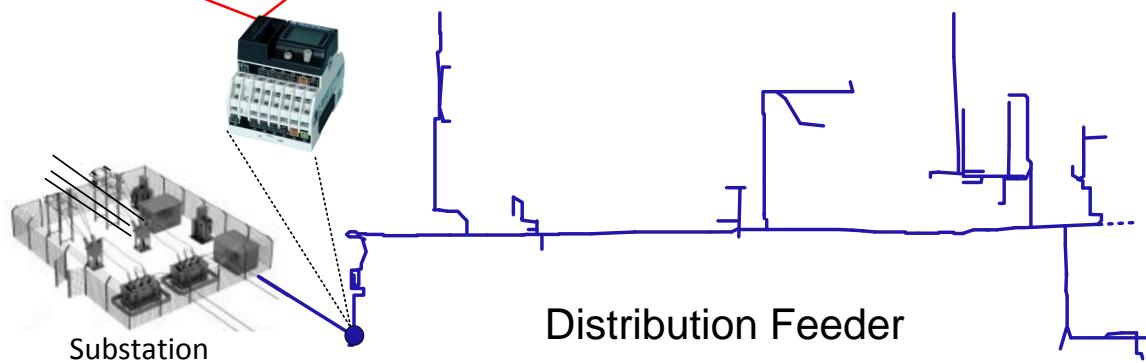
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IEEE Trans. on Power
Systems, Nov 2018

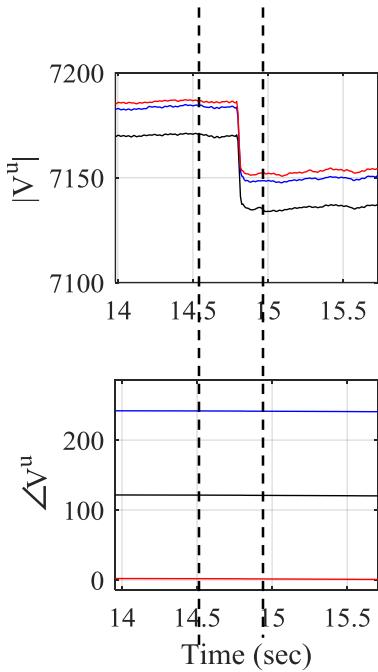
Locating Source of Events



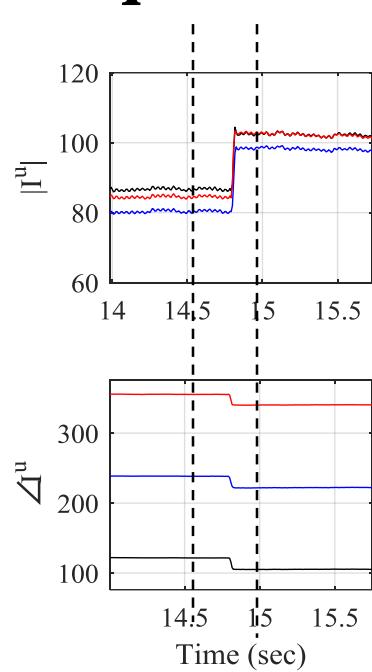
- 1) Is an event occurred on distribution feeder?
- 2) If yes, where is the exact location?
- 3) What we need for location identification?



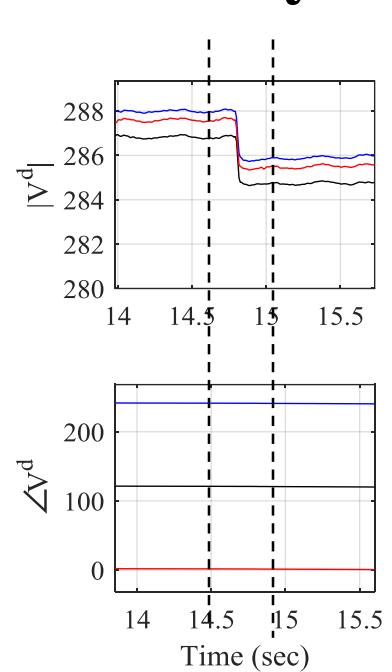
Equivalent Circuit Analysis



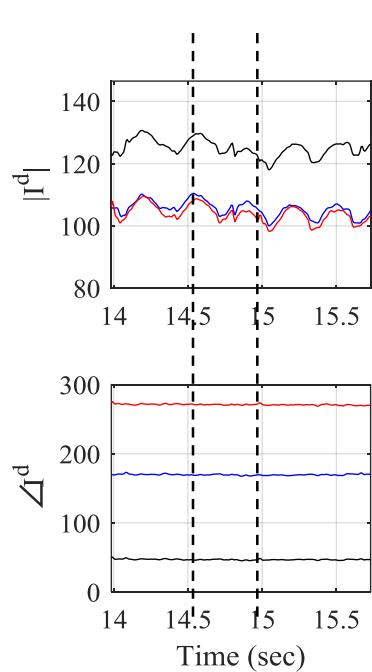
ΔV^u



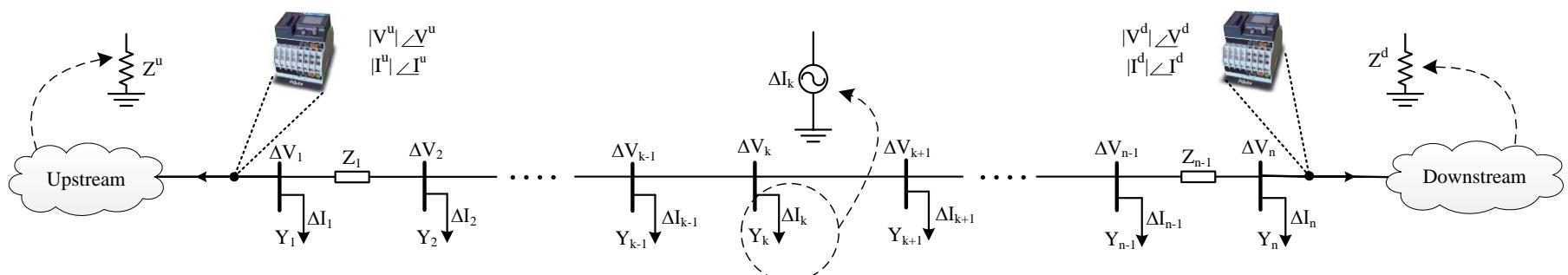
ΔI^u



ΔV^d

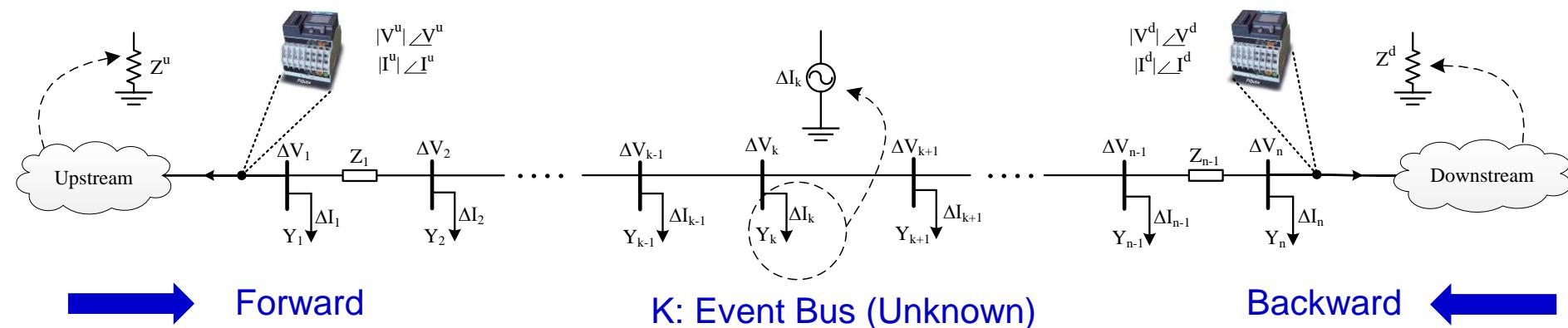
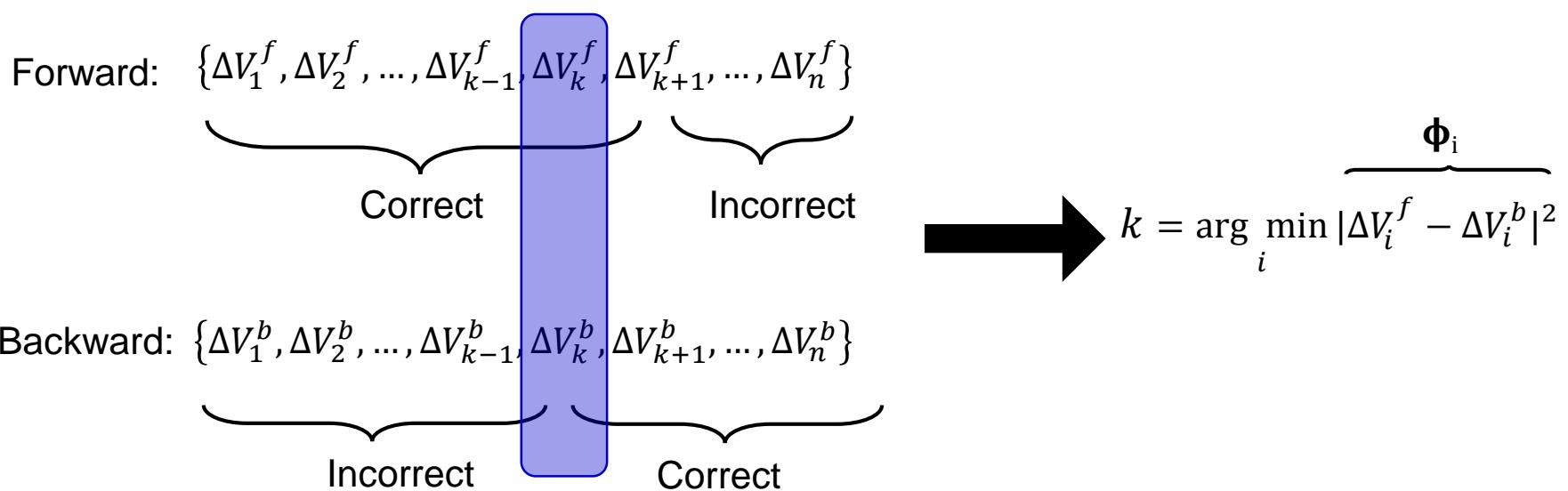


ΔI^d

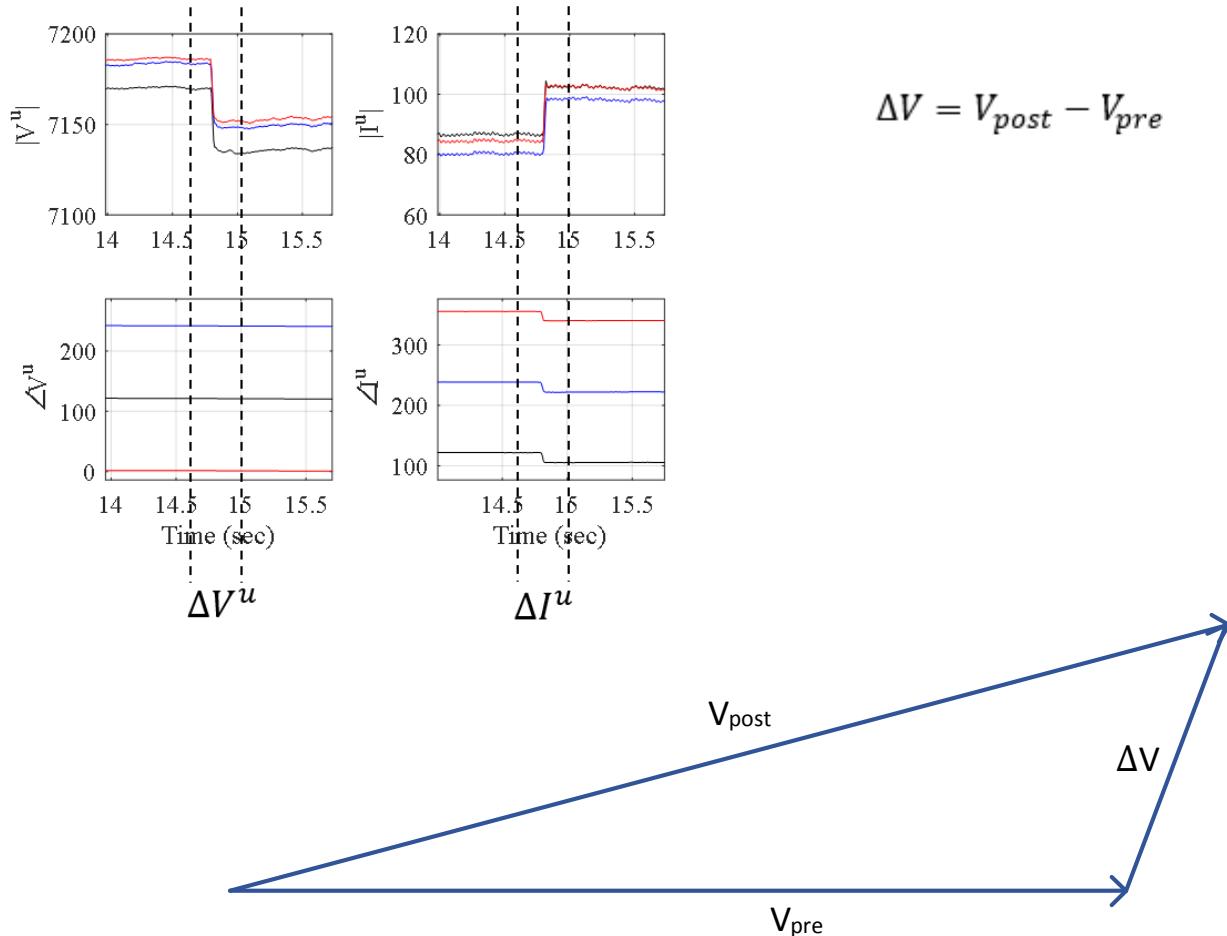


K: Event Bus (Unknown)

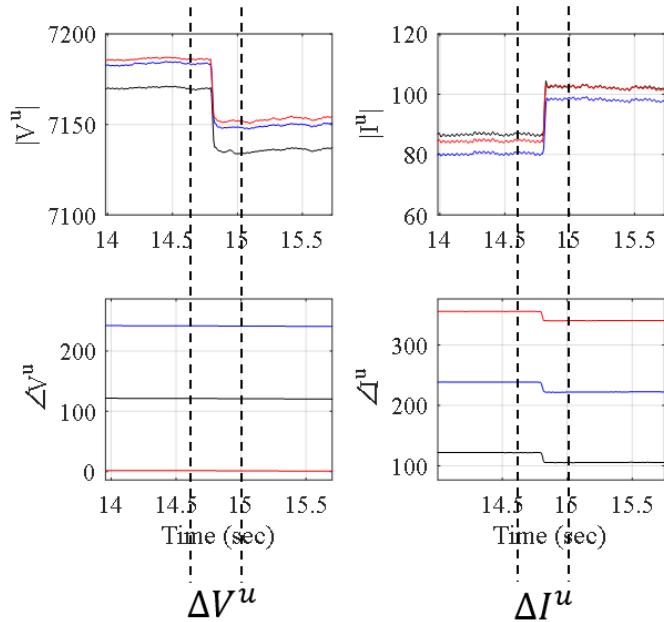
Voltage Comparison



Micro-PMU Measurements

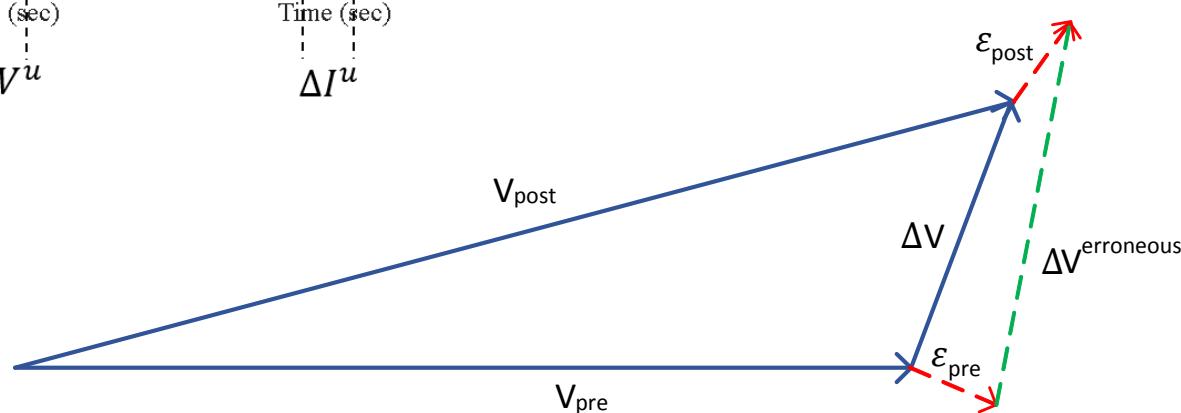


Micro-PMU Measurements

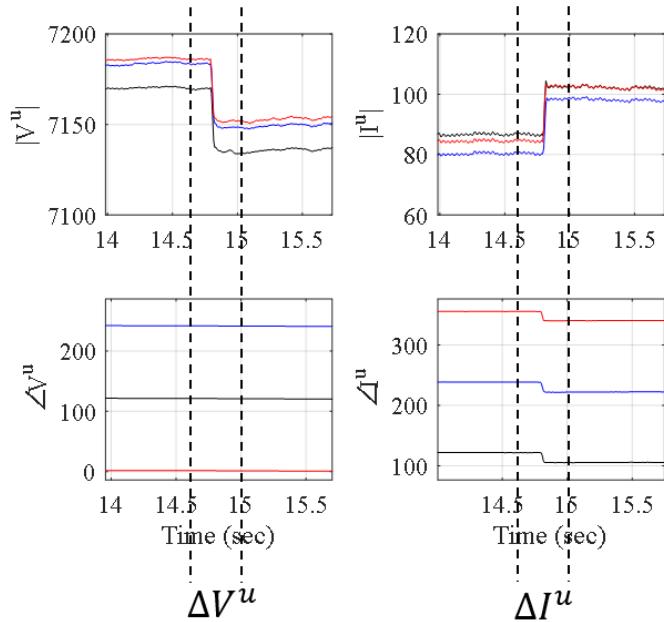


$$\Delta V = V_{post} - V_{pre}$$

$$\begin{aligned}\Delta V^{\text{erroneous}} &= V_{post} + \varepsilon_{post} - (V_{pre} + \varepsilon_{pre}) \\ &= \Delta V + (\varepsilon_{post} - \varepsilon_{pre})\end{aligned}$$

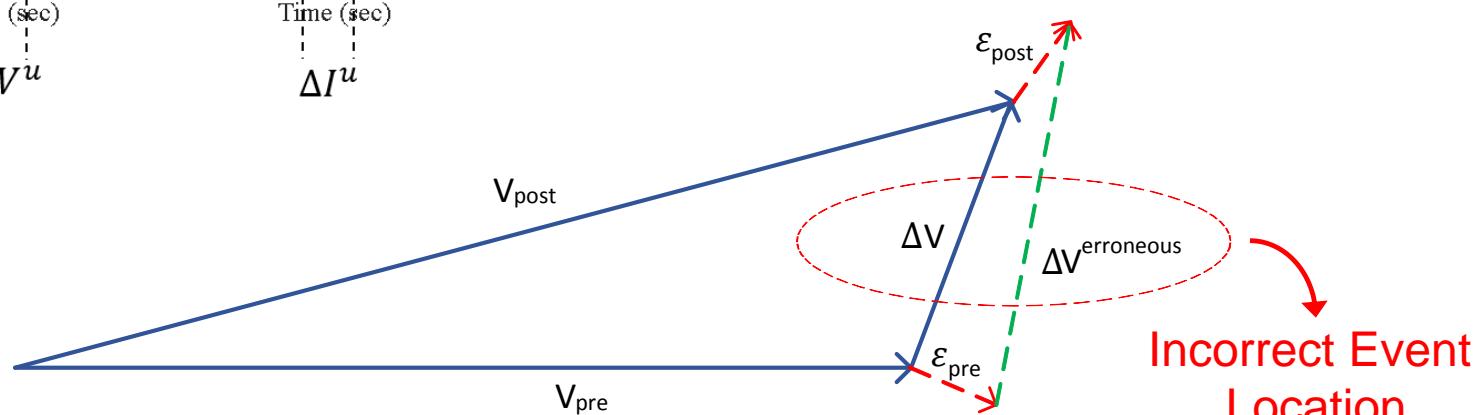


Micro-PMU Measurements

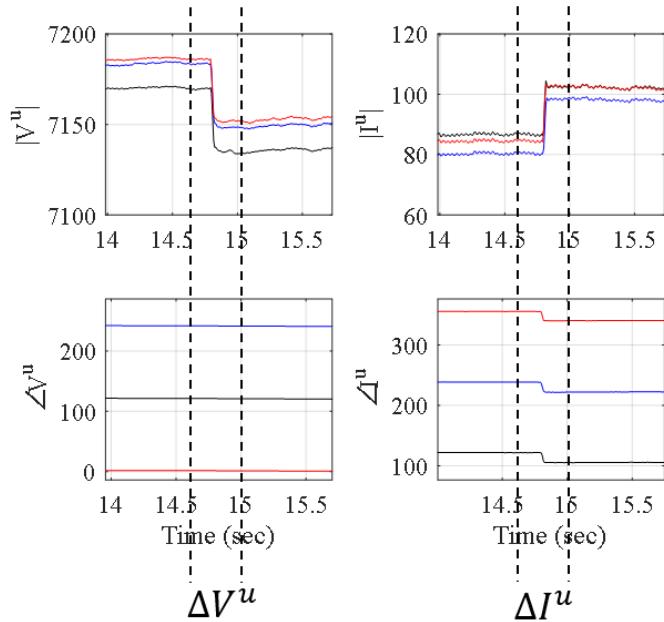


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Micro-PMU Measurements

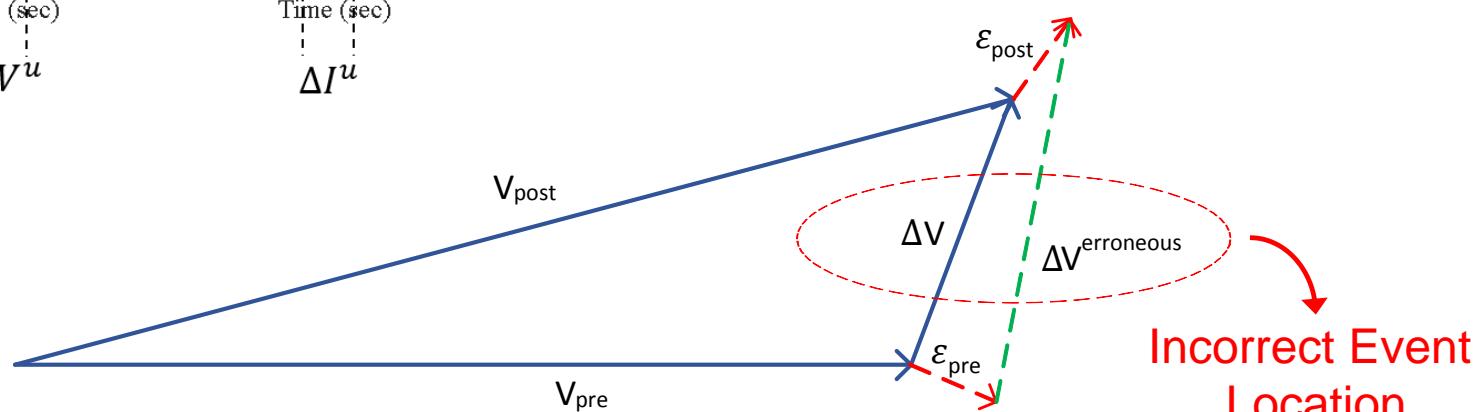


Intentional?

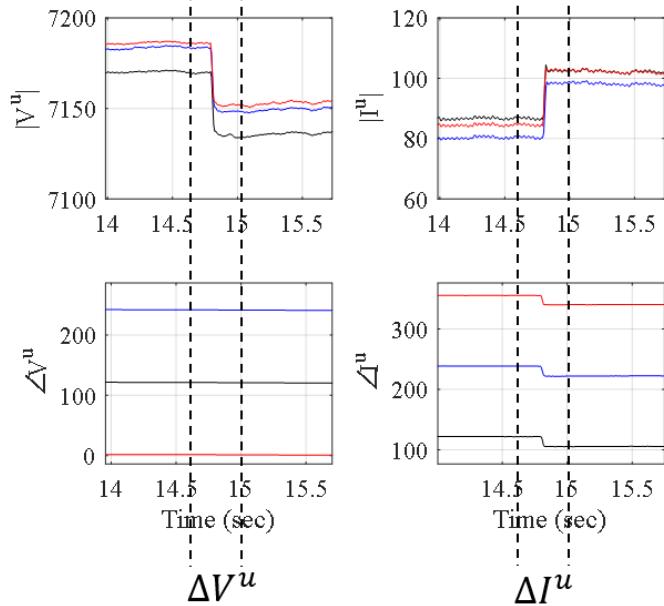
$$\Delta V = V_{post} - V_{pre}$$

$$\Delta V^{\text{erroneous}} = V_{post} + \varepsilon_{post} - (V_{pre} + \varepsilon_{pre})$$

$$= \Delta V + (\varepsilon_{post} - \varepsilon_{pre})$$



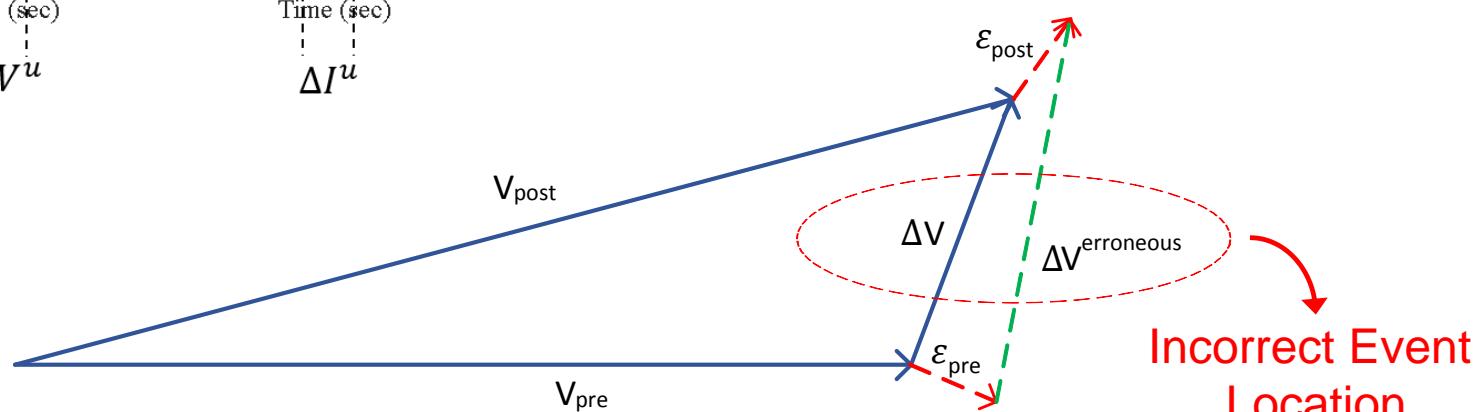
Micro-PMU Measurements



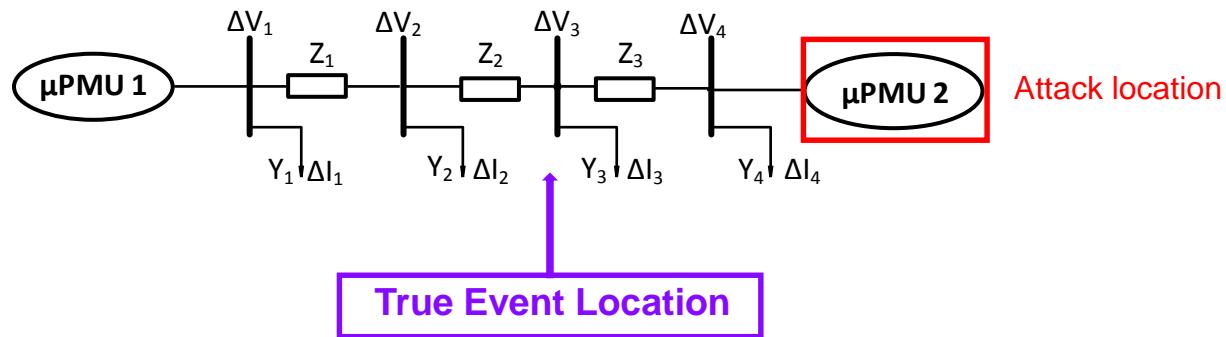
False Data
Injection Attack

$$\Delta V = V_{post} - V_{pre}$$

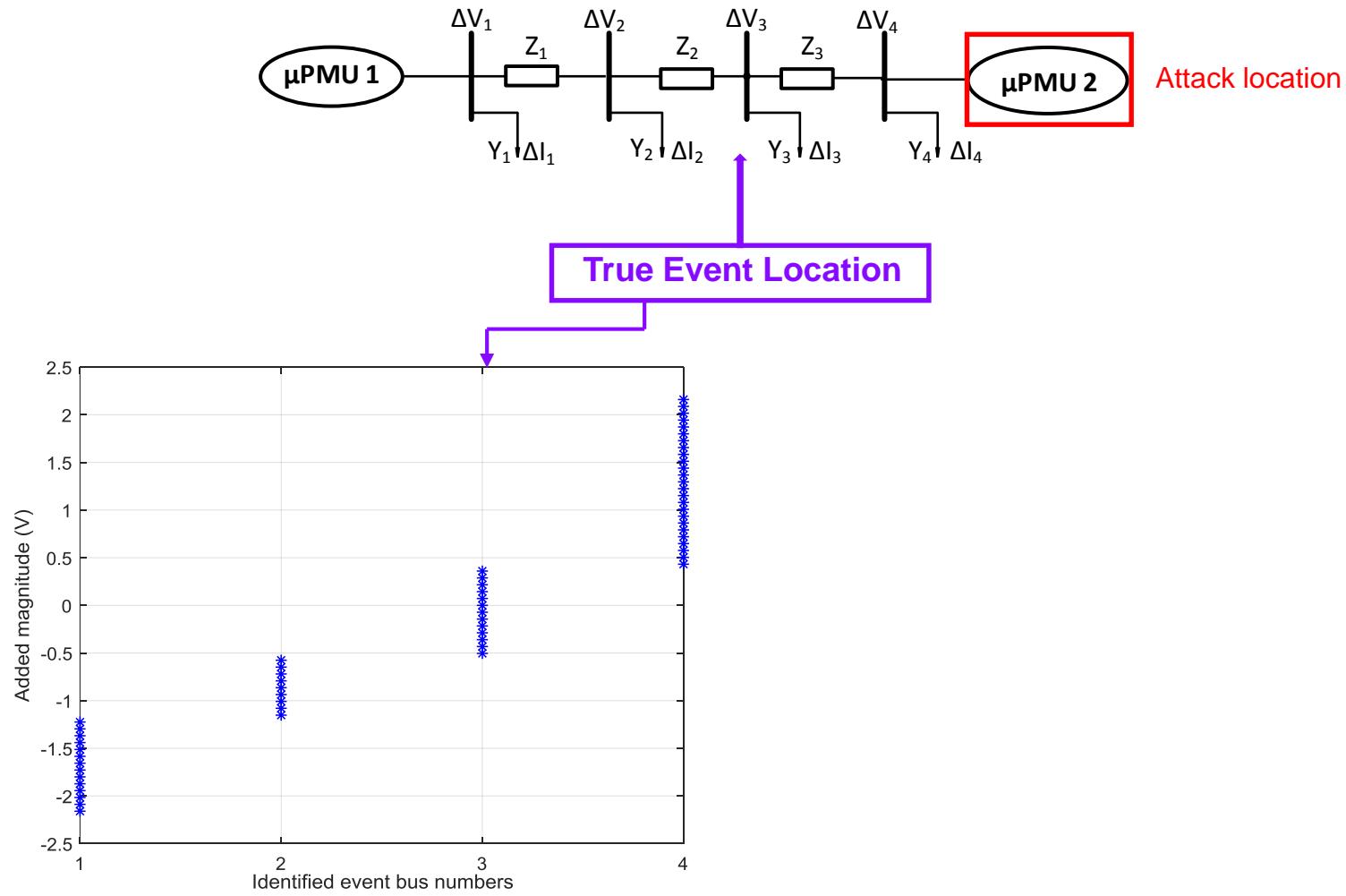
$$\begin{aligned}\Delta V^{\text{erroneous}} &= V_{post} + \varepsilon_{post} - (V_{pre} + \varepsilon_{pre}) \\ &= \Delta V + (\varepsilon_{post} - \varepsilon_{pre})\end{aligned}$$



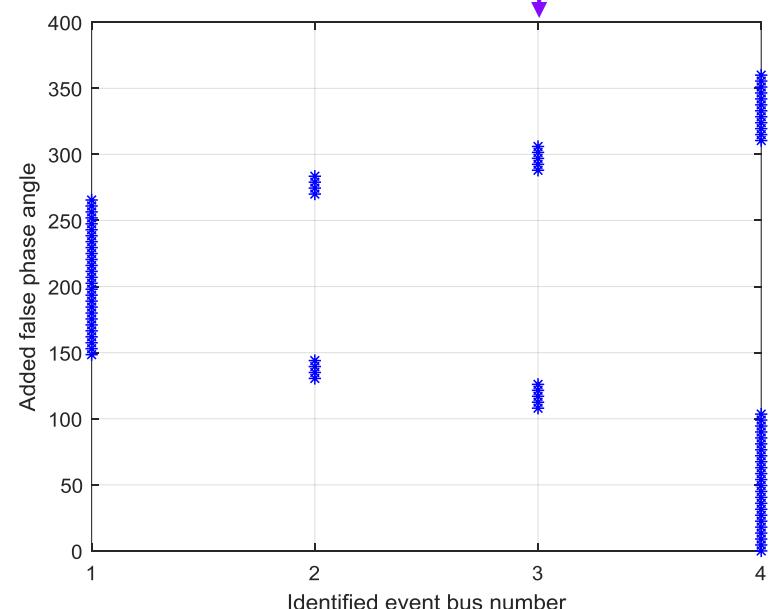
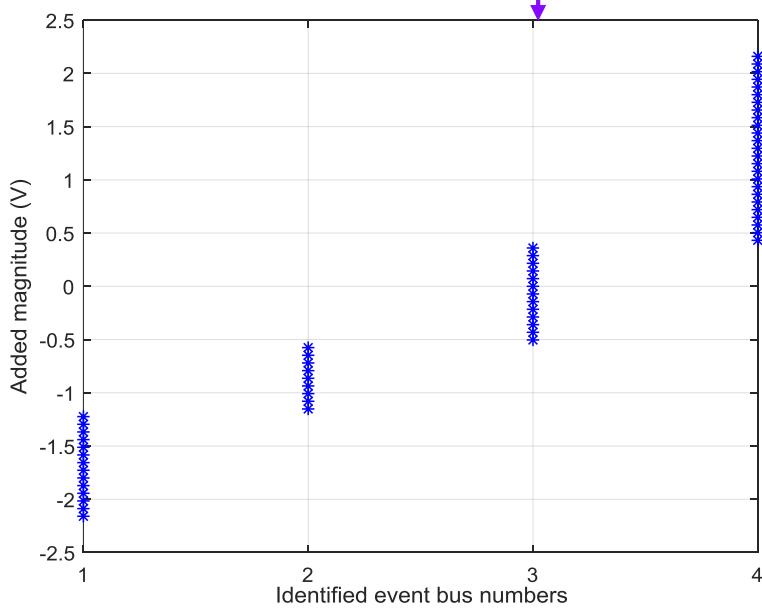
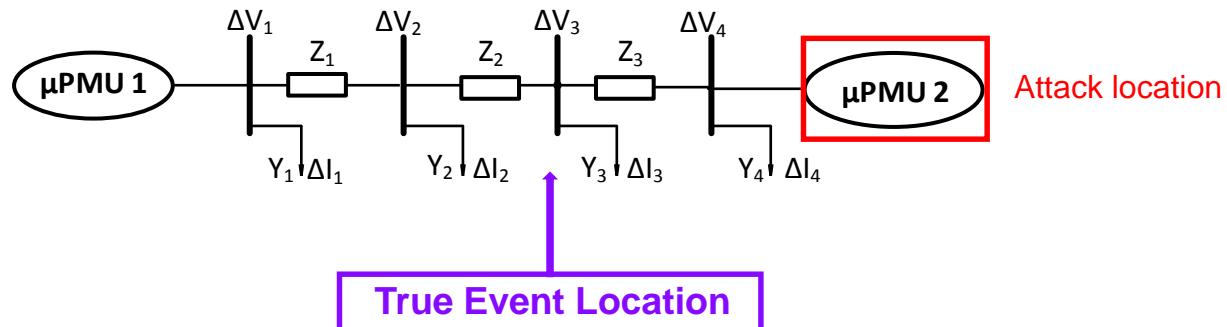
FDIA Against Micro-PMU data



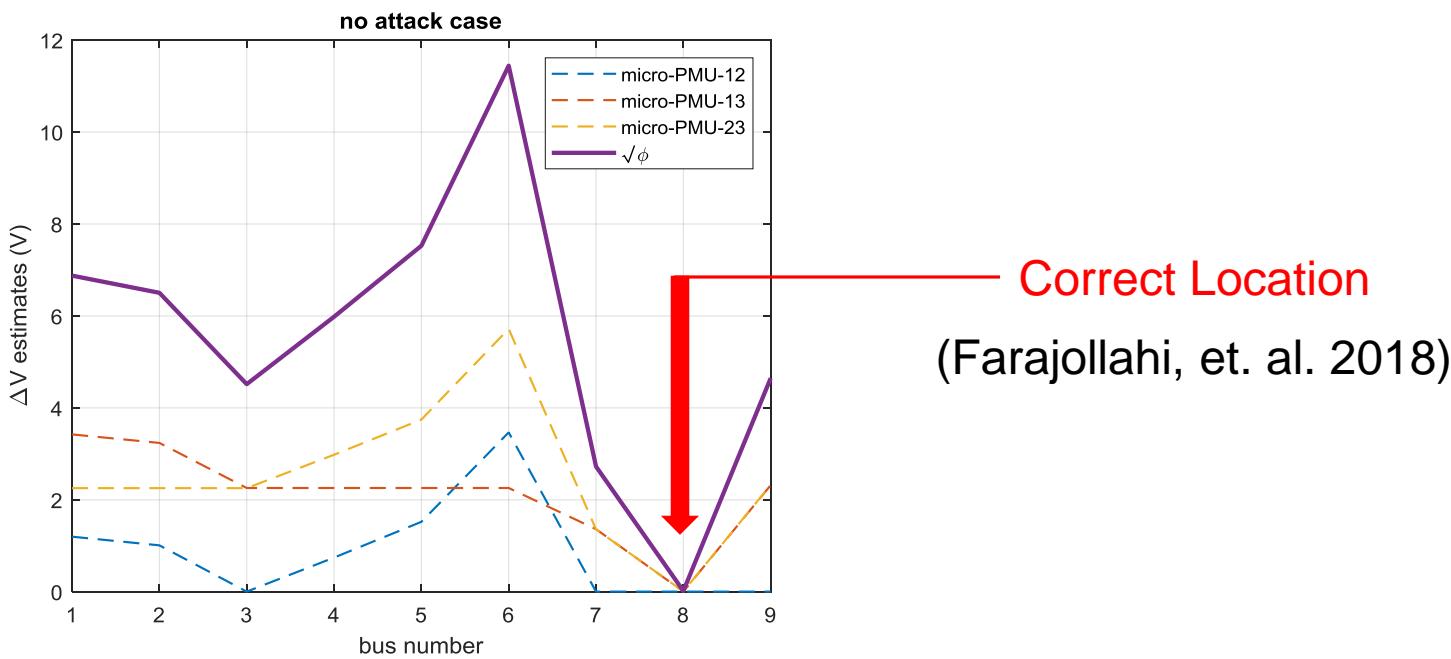
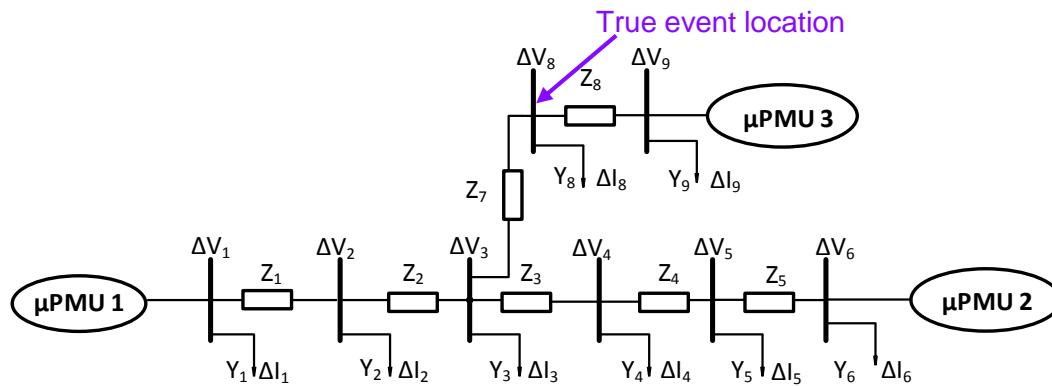
FDIA Against Micro-PMU data



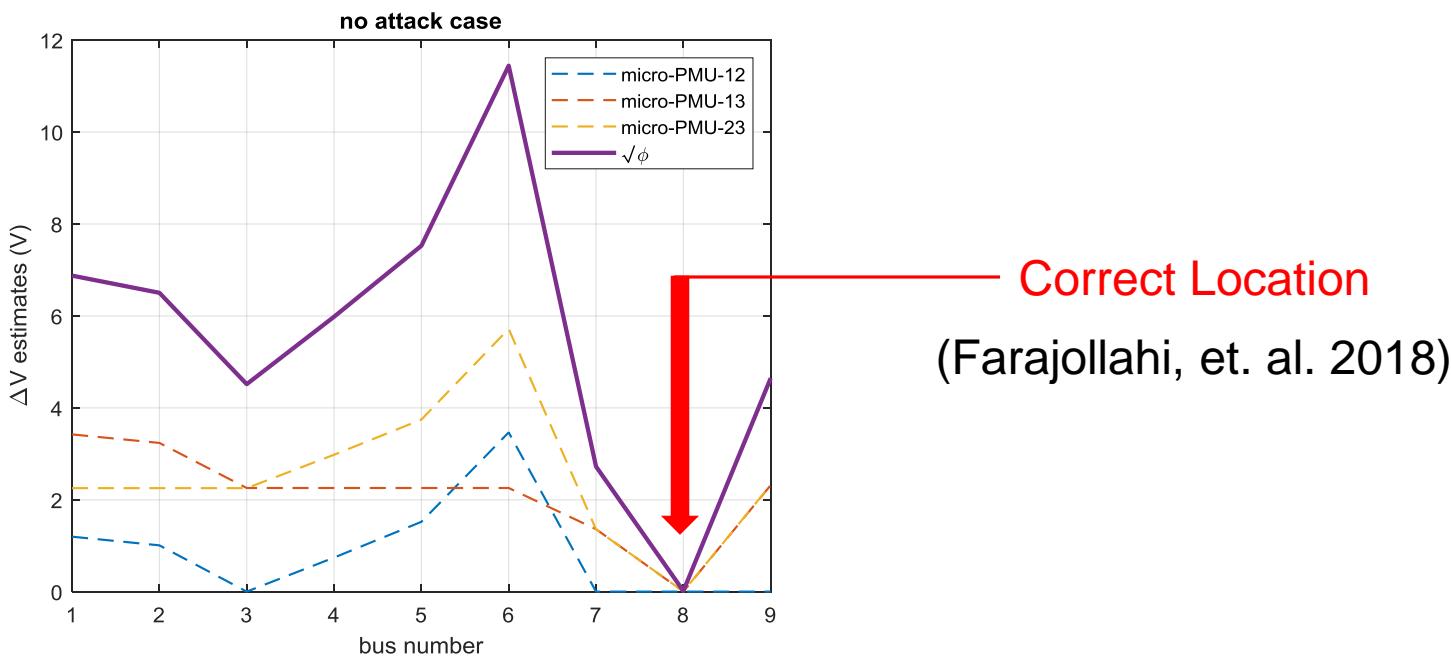
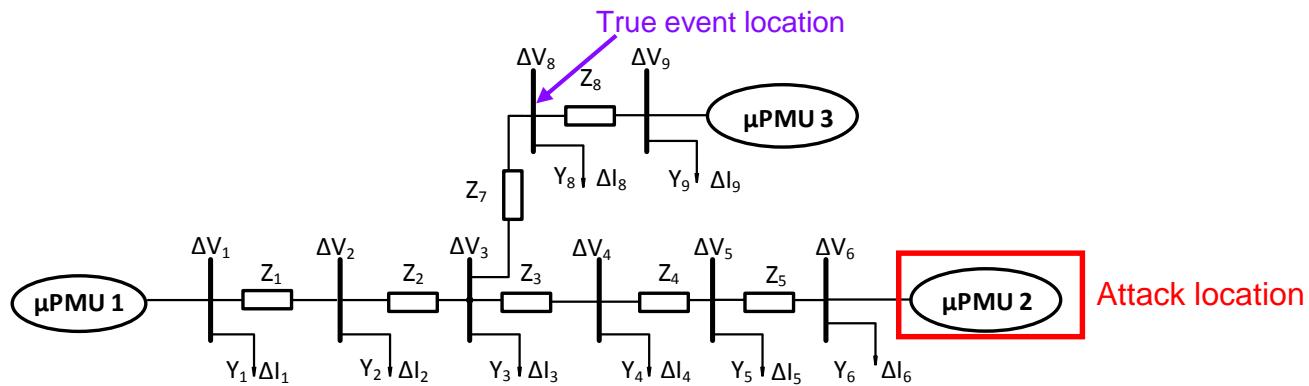
FDIA Against Micro-PMU data



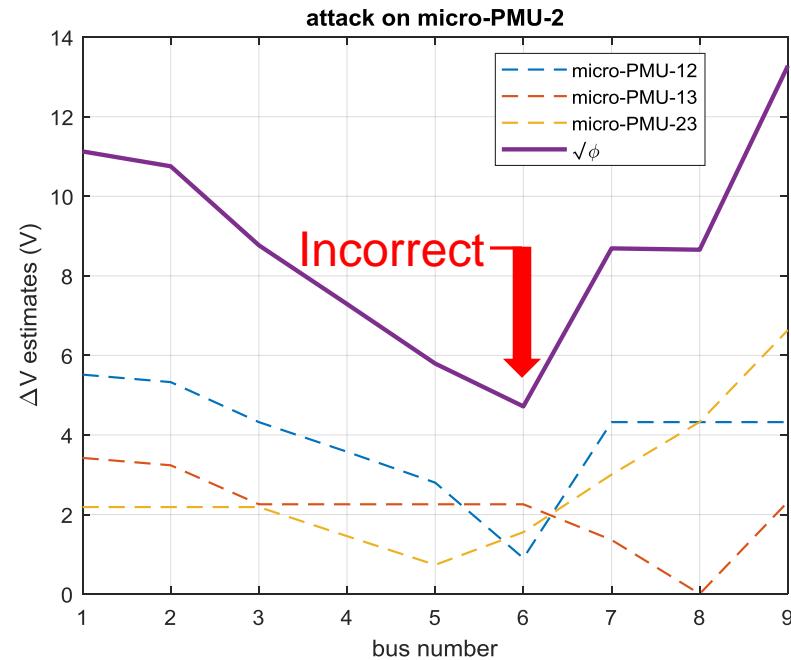
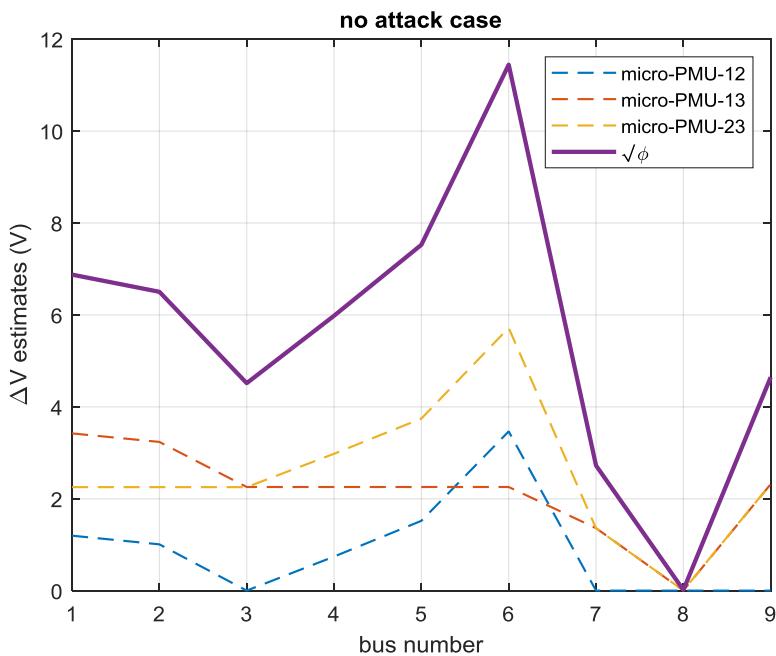
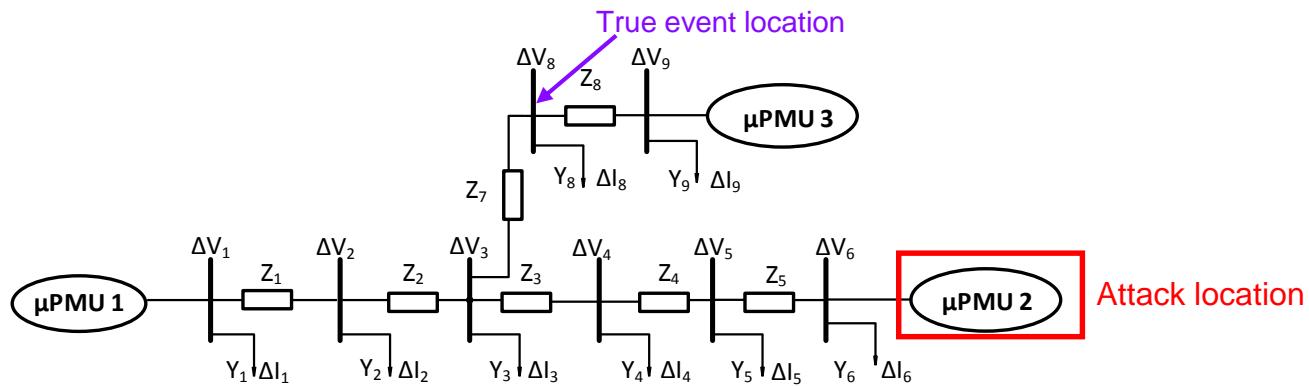
Effects of bad measurements in Micro-PMU data



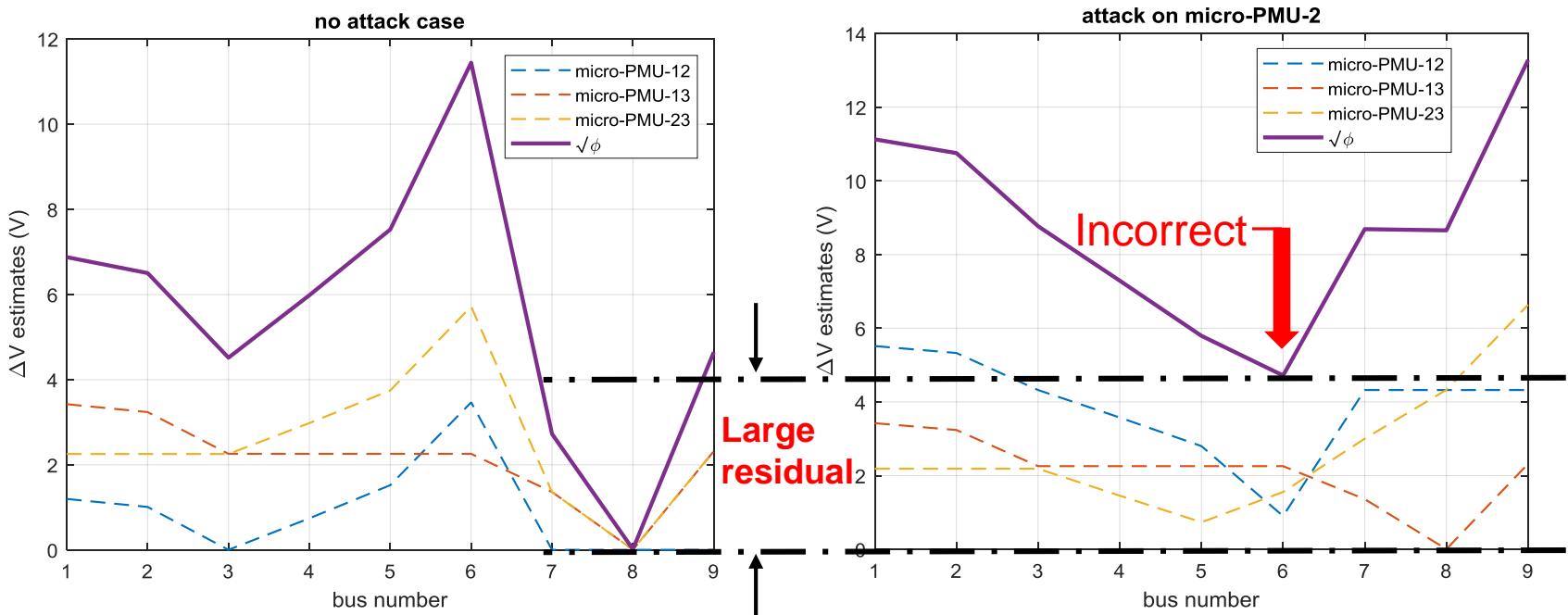
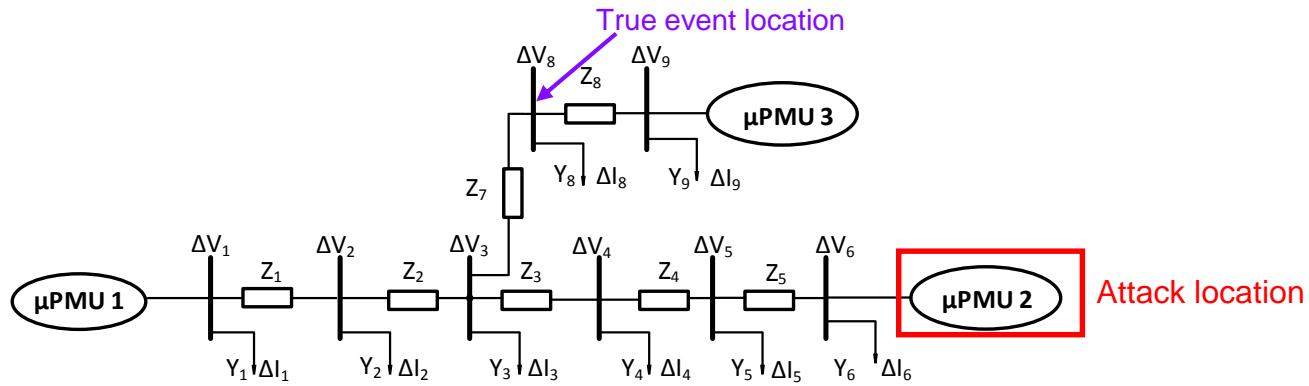
Effects of bad measurements in Micro-PMU data



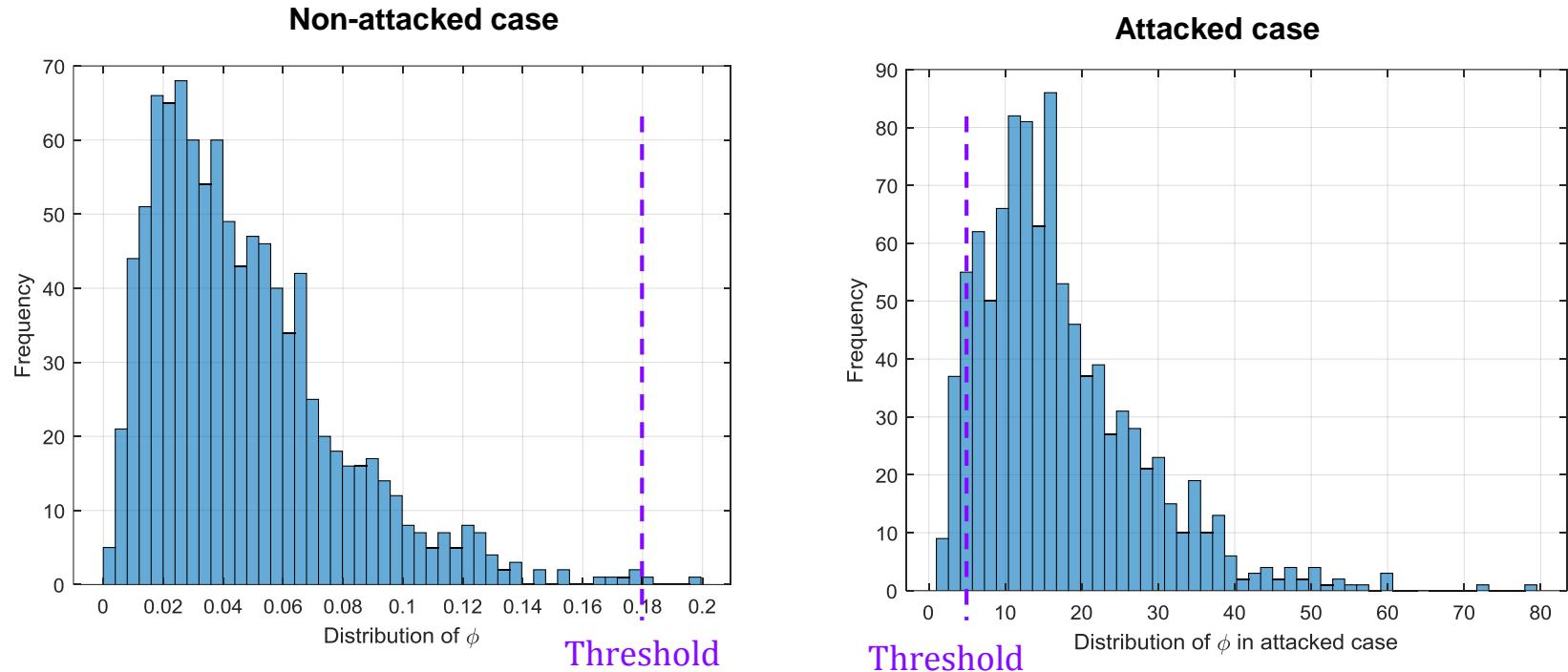
Effects of bad measurements in Micro-PMU data



Effects of bad measurements in Micro-PMU data



Proposed Attack Detection Method



$$\mathbb{I}(\varphi > \tau) = 1$$

$prob(\varphi_i > \tau \mid \varphi_i \text{ is chi-squared}) = \alpha$

$$\varphi_i = |\Delta V_i^f - \Delta V_i^b|^2$$

Proposed Attack Identification Method

$$\arg \min_j \quad \frac{1}{N-1} \sum_{j=1}^N (\Delta V I_j)^2 - \left(\frac{1}{N-1} \sum_{j=1}^N \Delta V I_j \right)^2$$

$$\text{subject to} \quad \sum_{j=1}^N I_j = N - 1$$

$$I_j \in \{1,0\}$$

Where

$$I_j = \begin{cases} 1, & \text{if } \mu\text{PMU } j \text{ is kept} \\ 0, & \text{if } \mu\text{PMU } j \text{ is dropped} \end{cases}$$

Proposed Attack Identification Method

$$\arg \min_j \quad \frac{1}{N-1} \sum_{j=1}^N (\Delta V I_j)^2 - \left(\frac{1}{N-1} \sum_{j=1}^N \Delta V I_j \right)^2$$

Variance across measurements in absence of dropped micro-PMU

$$\text{subject to} \quad \sum_{j=1}^N I_j = N - 1$$

$$I_j \in \{1,0\}$$

Where

$$I_j = \begin{cases} 1, & \text{if } \mu\text{PMU } j \text{ is kept} \\ 0, & \text{if } \mu\text{PMU } j \text{ is dropped} \end{cases}$$

Proposed Attack Identification Method

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Variance across measurements in absence of dropped micro-PMU

$$\text{subject to} \quad \sum_{j=1}^N I_j = N - 1$$

The number of micro-PMUs kept

$$I_j \in \{1, 0\}$$

Where

$$I_j = \begin{cases} 1, & \text{if } \mu\text{PMU } j \text{ is kept} \\ 0, & \text{if } \mu\text{PMU } j \text{ is dropped} \end{cases}$$

Proposed Attack Identification Method

$$\arg \min_j \quad \frac{1}{N-1} \sum_{j=1}^N (\Delta V I_j)^2 - \left(\frac{1}{N-1} \sum_{j=1}^N \Delta V I_j \right)^2$$

Variance across measurements in absence of dropped micro-PMU

$$\text{subject to} \quad \sum_{j=1}^N I_j = N - 1$$

The number of micro-PMUs kept

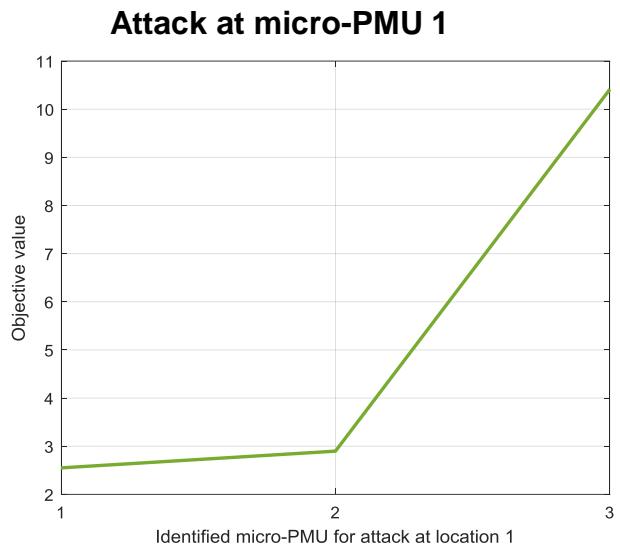
$$I_j \in \{1,0\}$$

Where

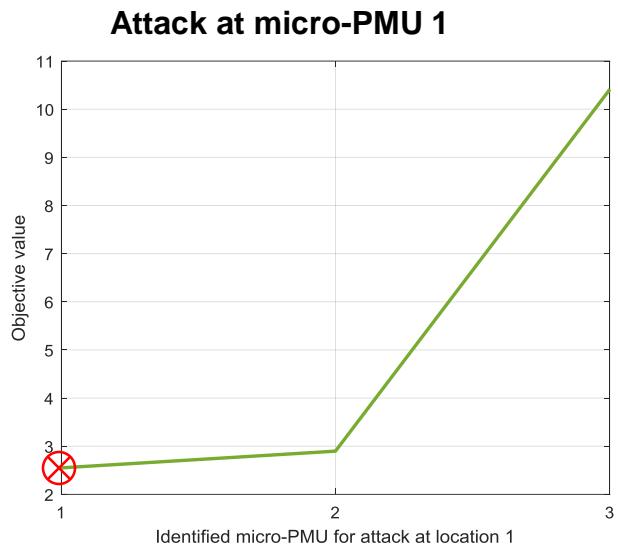
$$I_j = \begin{cases} 1, & \text{if } \mu\text{PMU } j \text{ is kept} \\ 0, & \text{if } \mu\text{PMU } j \text{ is dropped} \end{cases}$$

Decision Variable

Identified affected μ PMU

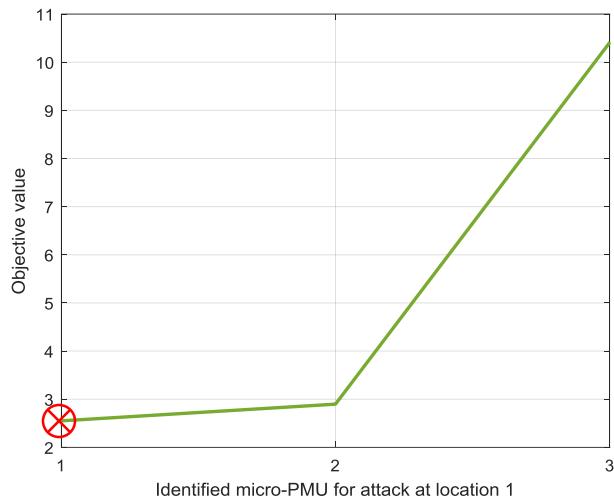


Identified affected μ PMU

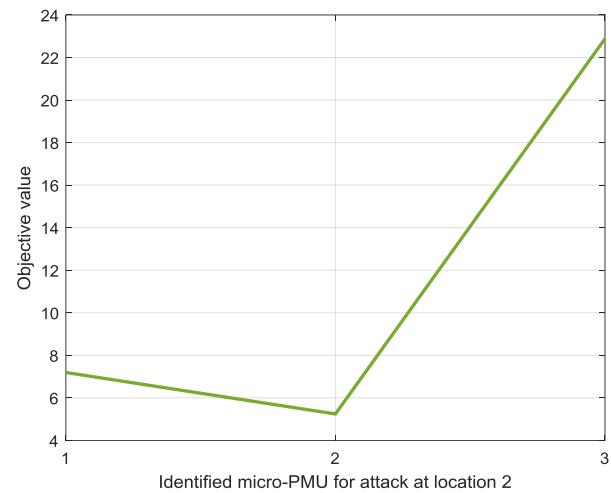


Identified affected μ PMU

Attack at micro-PMU 1

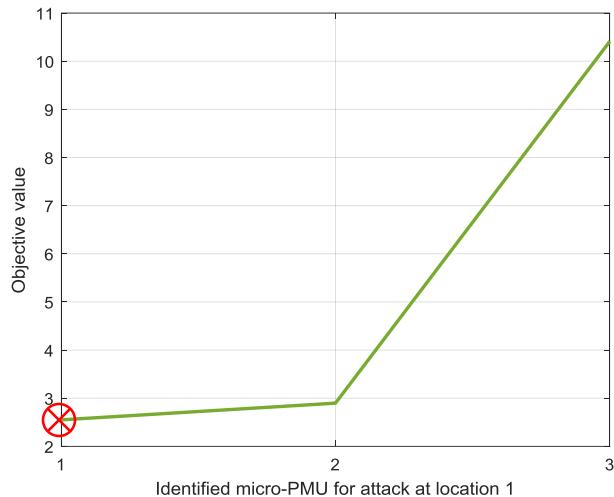


Attack at micro-PMU 2



Identified affected μ PMU

Attack at micro-PMU 1

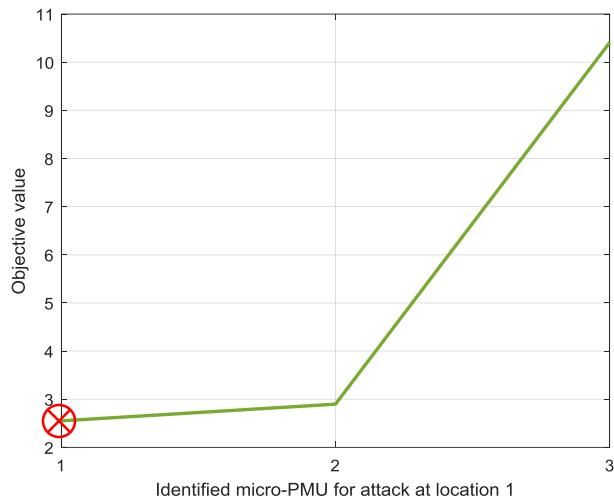


Attack at micro-PMU 2

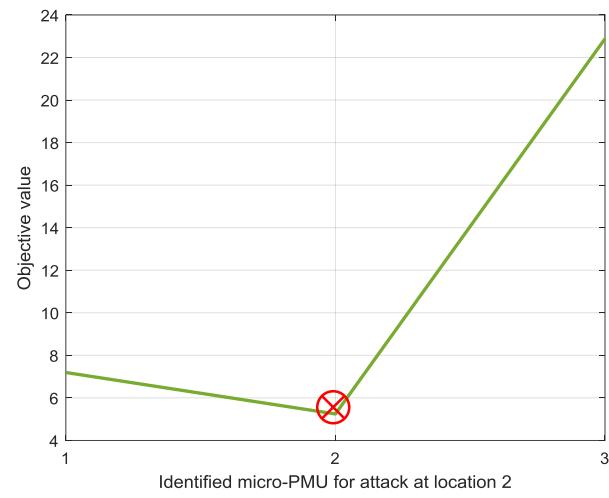


Identified affected μ PMU

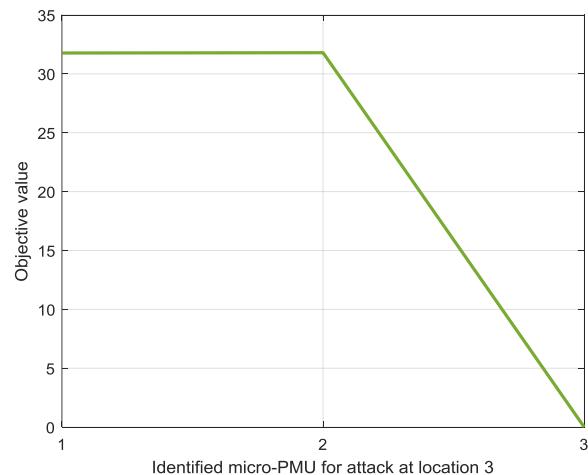
Attack at micro-PMU 1



Attack at micro-PMU 2

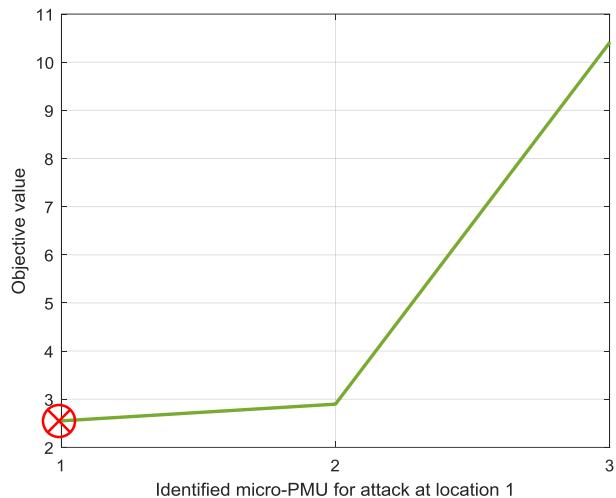


Attack at micro-PMU 3



Identified affected μ PMU

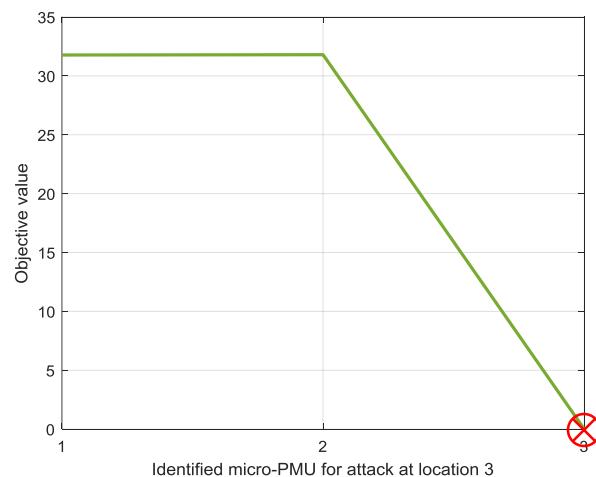
Attack at micro-PMU 1



Attack at micro-PMU 2



Attack at micro-PMU 3



References

- [1] Mohsenian-Rad, Hamed, Emma Stewart, and Ed Cortez. "Distribution synchrophasors: Pairing big data with analytics to create actionable information." *IEEE Power and Energy Magazine* 16.3 (2018): 26-34.
- [2] Farajollahi, Mohammad, et al. "Locating the source of events in power distribution systems using micro-pmu data." *IEEE Transactions on Power Systems* 33.6 (2018): 6343-6354.
- [3] He, Youbiao, Gihan J. Mendis, and Jin Wei. "Real-time detection of false data injection attacks in smart grid: A deep learning-based intelligent mechanism." *IEEE Transactions on Smart Grid* 8.5 (2017): 2505-2516.
- [4] Amini, Sajjad, et al. "Hierarchical Location Identification of Destabilizing Faults and Attacks in Power Systems: A Frequency-Domain Approach." *IEEE Transactions on Smart Grid* (2017).
- [5] R. Deng, P. Zhuang and H. Liang, "False Data Injection Attacks Against State Estimation in Power Distribution Systems," in *IEEE Transactions on Smart Grid*.
- [6] M. Kamal, M. Farajollahi, H. Mohsenian-Rad, "Analysis of Cyber Attacks Against Distribution Synchrophasors: The Case of Event Location Identification," to be submitted May 2019.
- [7] M. Farajollahi, A. Shahsavari, H. Mohsenian-Rad, "Tracking State Estimation in Distribution Networks Using Distribution-level Synchrophasor Data," accepted for publication in *IEEE Power & Energy Society General Meeting*, Portland, OR, August 2018.
- [8] M. Farajollahi, A. Shahsavari and H. Mohsenian-Rad, "Location Identification of Distribution Network Events Using SynchrophasorData" , in Proc. of North American Power Symposium, Morgantown, WV, September 2017.
- [9] M. Farajollahi, A. Shahsavari, and H. Mohsenian-Rad, "Location Identification of High Impedance Faults Using Synchronized Harmonic Phasors" in Proc. of the IEEE Power & Energy Society Conference on Innovative Smart Grid Technologies (ISGT), Washington, DC, April 2017.